

<b>Notice of References Cited</b>	Application/Control No. 10/624,680	Applicant(s)/Patent Under Reexamination OTSUKI, TETSUYA	
	Examiner Long K. Tran	Art Unit 2818	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,331,203	07-1994	Wojnarowski et al.	257/698
	B	US-6,861,737	03-2005	Jeong et al.	257/680
	C	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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